

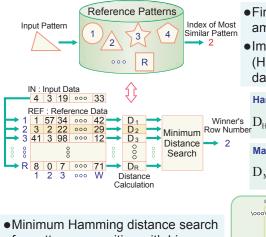
Associative Memory for High-Speed Nearest Hamming/Manhattan Distance Search with Large Reference Pattern Number

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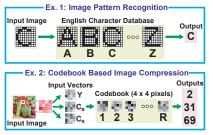
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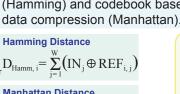
Associative Memory Functionality

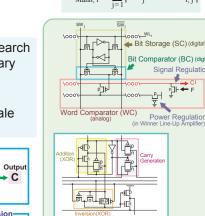


- for pattern recognition with binary (black/white) images
- Manhattan distance for many applications with color/gray-scale images



- Finding the nearest match pattern among R reference patterns.
- Important for pattern recognition (Hamming) and codebook based data compression (Manhattan).





ed Stored 1 Bit i, 12 000 Stored Bit i, 12

Subtractor (k bit)

Absolute Value

000

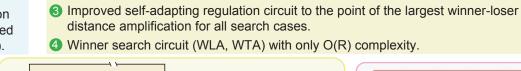
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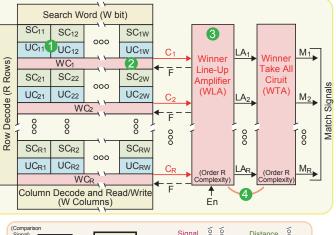
20\만 분 F 오 Feedback Line

plb

26

Winner's $D_{\text{Hamm, i}} = \sum (IN_i \oplus REF_{i, j})$ Manhattan Distance $D_{\text{Manh, i}} = \sum_{i=1}^{n} |IN_i - REF_{i, i}|$ Bit Storage (SC) (digital) Bit Comparator (BC) (digital) Signal Regulation



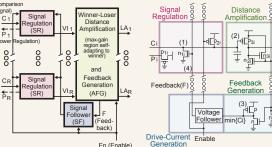


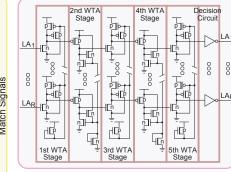
Associative Memory Architecture

2 A fast and static analog-current-encoding of the word-comparison results.

K-bit subtractors and absolute value calculators (UC, WC) within the memory field.

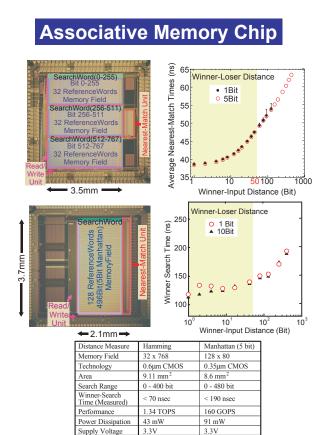
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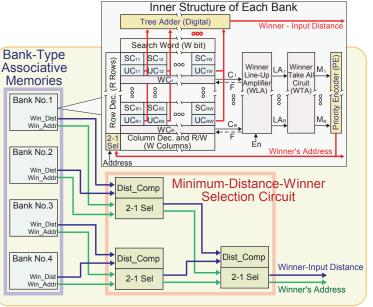


- Each stage amplifies the differences by a voltage-currentvoltage transformation.
- Enough amplification magnitude (by a factor 20-50)
- The current on C_{win} is the smallest and the voltage of C_{win} is the lowest.
- The current-source capability of p_{3win} is the largest and the voltage of LAwin is the highest.
- The feedback voltage of F is approximately equal to that of Cwin.
- For larger winner-input distance the voltage F becomes higher and n_{1i} have larger current-sink capability.

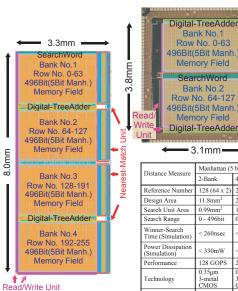
- •K-bit digital subtractor and absolute-value calculator are needed to realize the Manhattan-distance-search.
- •All unit comparators and all word comparators calculate the distance between search word and stored word in parallel.



- 9.11mm² test chip designed in 0.6µm CMOS technology (Hamming) and 7.49mm² test chip designed in 0.35µm CMOS technology (Manhattan).
- High-speed minimum distance search at < 70ns (Hamming) and at < 190ns (Manhattan).
- Low power dissipation of < 43mW (Hamming) and of < 91mW (Manhattan).



- Each of the 4 banks searches its local winner independently.
- The minimum distance winner selection circuit determines the global winner among 4 local winners.
- Each bank has the circuitry (PE, tree adder, digital distance output port) for digital calculation of the local winner.



Manhattan (5 bit)

11.8mm²

99mm

- 496hit

260nsec

330mW

).35um

3.3V

Supply Voltage

4-Bank

256 (64 x 4

26.5mm²

1.97mm

- 496bit

280nse

640mW

229 GOPS

).35um 3-metal CMOS

3.3V

- 11.8mm² and 26.5mm² test chips for bank-type associative memories are designed in 0.35µm CMOS technology with 3 metal layers.
- 2/4 bank associative memories have the function of minimum Manhattan distance search among 128/256 reference patterns.
- Each chip has high performance at low power dissipation.

Conclusions

- Associative memories without and with (for large pattern number) bank-type architectures are proposed for fully-parallel minimum distance search.
- Test chips are designed in 0.6µm (Hamming) and in 0.35µm CMOS technologies.
- Measured data indicates sufficient performance for application in mobile real-time systems.

Bank-Type Associative Memory